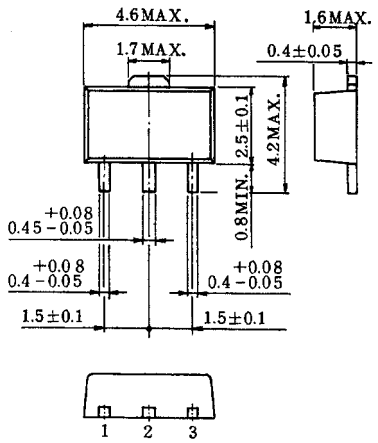
TOSHIBA Transistor Silicon NPN Epitaxial Type (PCT Process)

RN5006

Motor Drive Circuit Applications
Power Amplifier Applications
Power Switching Applications

- With built-in bias resistors
- Simplify circuit design
- Reduce a quantity of parts and manufacturing process
- Small flat package
- P_C = 1~2W (mounted on ceramic substrate)
- Complementary to RN6006

Unit: mm



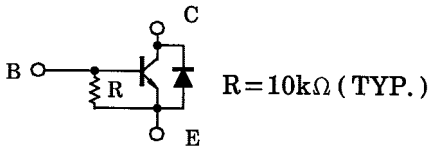
1. BASE
2. COLLECTOR (HEAT SINK)
3. EMITTER

PW-MINI

JEDEC	—
JEITA	SC-62
TOSHIBA	2-5K1A

Weight: 0.05g (typ.)

Equivalent Circuit



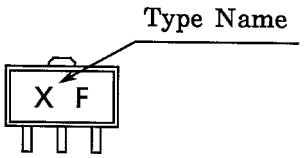
Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Rating	Unit
Collector-base voltage		V_{CBO}	10	V
Collector-emitter voltage		V_{CEO}	10	V
Emitter-base voltage		V_{EBO}	6	V
Collector current	DC	I_C	2	A
	Pulse (Note1)	I_{CP}	4	
Base current		I_B	0.4	A
Collector power dissipation		P_C	500	mW
Collector power dissipation		P_C *	1000	mW
Junction temperature		T_j	150	°C
Storage temperature range		T_{stg}	−55~150	°C

Note: Pulse width ≦ 10ms, duty cycle ≦ 30 %

* : Mounterd on ceramic substrate ($250mm^2 \times 0.8t$)

Marking



Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Collector cut-offcurrent	I_{CBO}	—	V_{CB} = 10V, I_E = 0	—	—	0.1	μA
Emitter cut-off current	I_{EBO}	—	V_{EB} = 6V, I_C = 0	0.462	0.60	0.857	mA
Collector-emitter breakdown voltage	$V_{(BR)CES}$	—	I_C = 1mA	10	—	—	V
DC current gain	$h_{FE\ (1)}$	—	V_{CE} = 1V, I_C = 0.5A	160	—	600	—
	$h_{FE\ (2)}$		V_{CE} = 1V, I_C = 4.0A	60	—	—	
Collector-emitter saturation voltage	$V_{CE\ (sat)}$	—	I_C = 2A, I_B = 0.05A	—	—	0.5	V
Transition frequency	f_T	—	V_{CE} = 1V, I_C = 0.5A	—	140	—	MHz
Collector output capacitance	C_{ob}	—	V_{CB} = 10V, I_E = 0, f = 1 MHz	—	30	—	pF
Resistor	R	—	—	7	10	13	kΩ

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